

IRFS4010-7PPbF

HEXFET® Power MOSFET

Applications

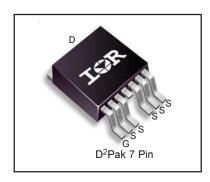
- High Efficiency Synchronous Rectification in SMPS
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

G S

V _{DSS}		100V
R _{DS(on)}	typ.	$\mathbf{3.3m}\Omega$
	max.	4.0m $Ω$
I _D		190A

Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dl/dt Capability
- Lead-Free



G	D	S
Gate	Drain	Source

Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	190	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	130	Α
I _{DM}	Pulsed Drain Current ①	740	
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	380	W
	Linear Derating Factor	2.5	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery ③	26	V/ns
T_J	Operating Junction and	-55 to + 175	°C
T _{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300	
	(1.6mm from case)		
	Mounting torque, 6-32 or M3 screw	10lb·in (1.1N·m)	

Avalanche Characteristics

E _{AS (Thermally limited)}	Single Pulse Avalanche Energy ②	330	mJ
I _{AR}	Avalanche Current ①	See Fig. 14, 15, 22a, 22b,	Α
E₄R	Repetitive Avalanche Energy ④	1	mJ

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ® 9		0.40	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ⑦®		40	

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Static @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.11		V/°C	Reference to 25°C, I _D = 5mA ^①
R _{DS(on)}	Static Drain-to-Source On-Resistance		3.3	4.0	mΩ	V _{GS} = 10V, I _D = 110A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
I_{DSS}	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 100V, V_{GS} = 0V$
				250	1	$V_{DS} = 100V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I_{GSS}	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100		$V_{GS} = -20V$
$R_{G(int)}$	Internal Gate Resistance		2.1		Ω	

Dynamic @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	210			S	$V_{DS} = 25V, I_{D} = 110A$
Q_g	Total Gate Charge		150	230	nC	I _D = 110A
Q_{gs}	Gate-to-Source Charge		36			$V_{DS} = 50V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		48			V _{GS} = 10V ④
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		102			$I_D = 110A$, $V_{DS} = 0V$, $V_{GS} = 10V$
t _{d(on)}	Turn-On Delay Time		19		ns	$V_{DD} = 65V$
t _r	Rise Time		56			I _D = 110A
t _{d(off)}	Turn-Off Delay Time		100			$R_G = 2.7\Omega$
t _f	Fall Time	_	48			V _{GS} = 10V ④
C _{iss}	Input Capacitance		9830			$V_{GS} = 0V$
C _{oss}	Output Capacitance		650			$V_{DS} = 50V$
C_{rss}	Reverse Transfer Capacitance		260		рF	f = 1.0MHz
C _{oss} eff. (ER)	Effective Output Capacitance (Energy Related)@		730			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V $
C _{oss} eff. (TR)	Effective Output Capacitance (Time Related)®		740			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V $

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			186	Α	MOSFET symbol
	(Body Diode)					showing the
I _{SM}	Pulsed Source Current			740		integral reverse
	(Body Diode) ①					p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 110A, V_{GS} = 0V \oplus$
t _{rr}	Reverse Recovery Time		60		ns	$T_{J} = 25^{\circ}C$ $V_{R} = 85V$,
			67			$T_J = 125^{\circ}C$ $I_F = 110A$
Q_{rr}	Reverse Recovery Charge		150		nC	$T_J = 25^{\circ}C$ di/dt = 100A/ μ s \oplus
			180			$T_J = 125^{\circ}C$
I _{RRM}	Reverse Recovery Current		4.7		Α	$T_J = 25^{\circ}C$
t _{on}	Forward Turn-On Time	Intrinsi	c turn-	on time	is negl	igible (turn-on is dominated by LS+LD)

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by T_{Jmax} , starting T_J = 25°C, L = 0.052mH R_G = 25 Ω , I_{AS} = 110A, V_{GS} =10V. Part not recommended for use above this value .
- $\label{eq:local_spectrum} \mbox{ } \mbox{I}_{SD} \leq 110\mbox{A}, \mbox{ } \mbox{di/dt} \leq 1310\mbox{A/\mu s}, \mbox{ } \mbox{V}_{DD} \leq \mbox{V}_{(BR)DSS}, \mbox{ } \mbox{T}_{J} \leq 175\mbox{°C}.$
- 4 Pulse width \leq 400 μ s; duty cycle \leq 2%.

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- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.

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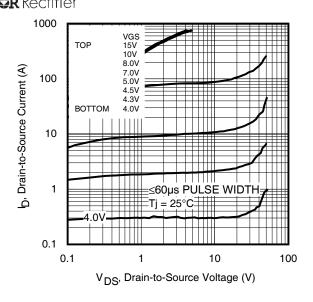


Fig 1. Typical Output Characteristics

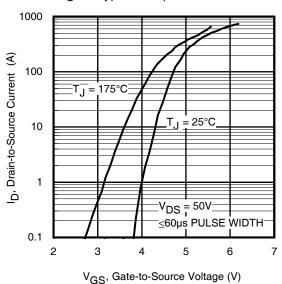


Fig 3. Typical Transfer Characteristics

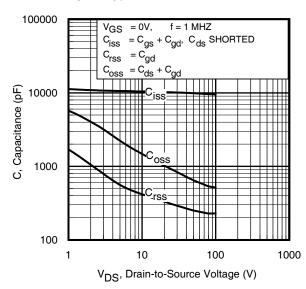


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage www.irf.com

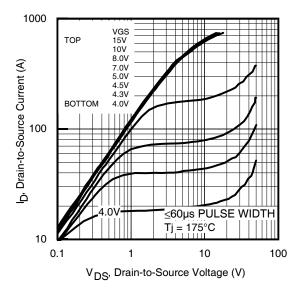


Fig 2. Typical Output Characteristics

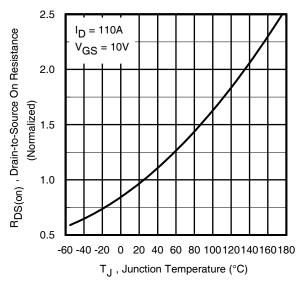


Fig 4. Normalized On-Resistance vs. Temperature

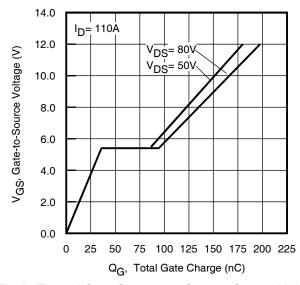


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

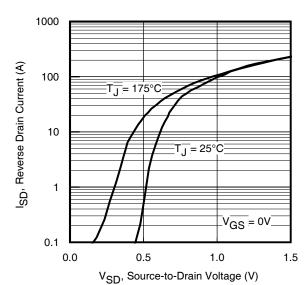


Fig 7. Typical Source-Drain Diode Forward Voltage

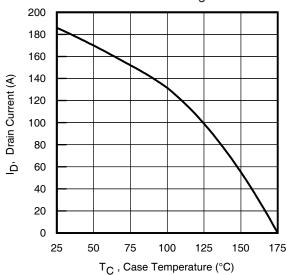
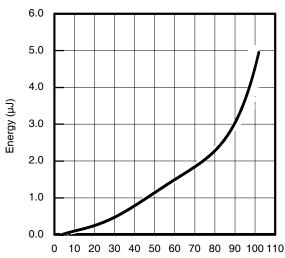


Fig 9. Maximum Drain Current vs. Case Temperature



 $V_{DS,}$ Drain-to-Source Voltage (V) Fig 11. Typical C_{OSS} Stored Energy

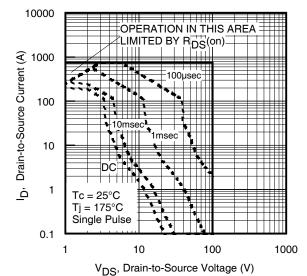


Fig 8. Maximum Safe Operating Area

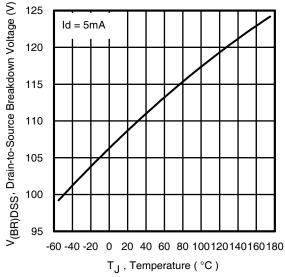


Fig 10. Drain-to-Source Breakdown Voltage

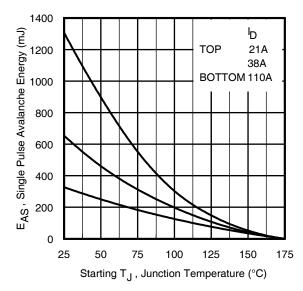


Fig 12. Maximum Avalanche Energy vs. DrainCurrent www.irf.com

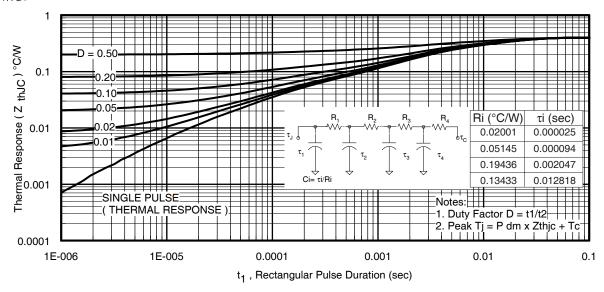


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

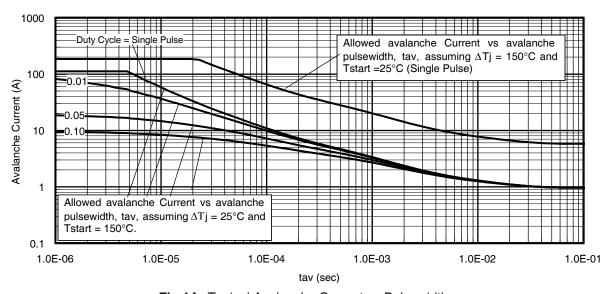


Fig 14. Typical Avalanche Current vs. Pulsewidth

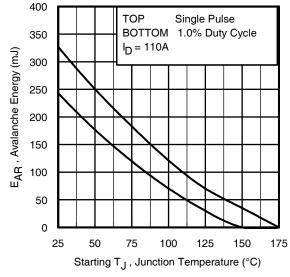


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
 - Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT_{imax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. l_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).

t_{av =} Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{th,JC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ (} 1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC} \\ I_{av} &= 2\Delta T / \text{ [} 1.3 \cdot BV \cdot Z_{th} \text{]} \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

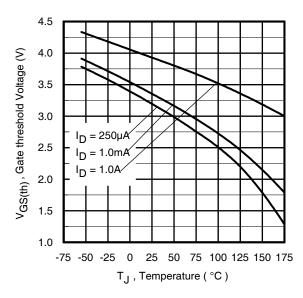


Fig 16. Threshold Voltage vs. Temperature

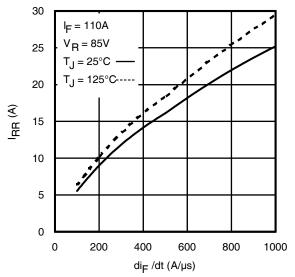


Fig. 18 - Typical Recovery Current vs. dif/dt

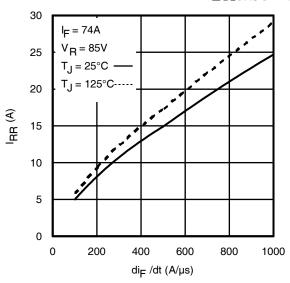


Fig. 17 - Typical Recovery Current vs. dif/dt

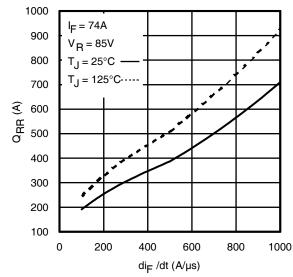


Fig. 19 - Typical Stored Charge vs. dif/dt

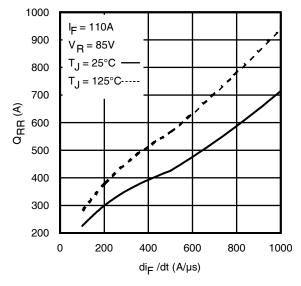


Fig. 20 - Typical Stored Charge vs. dif/dt

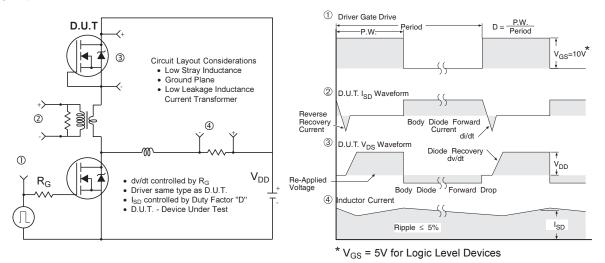


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

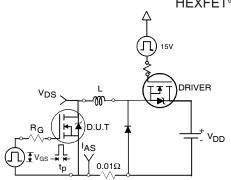


Fig 22a. Unclamped Inductive Test Circuit

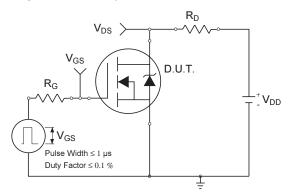


Fig 23a. Switching Time Test Circuit

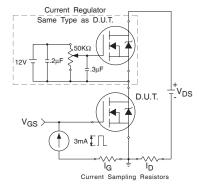


Fig 24a. Gate Charge Test Circuit www.irf.com

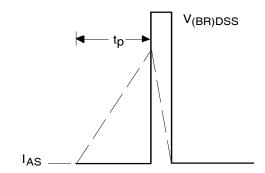


Fig 22b. Unclamped Inductive Waveforms

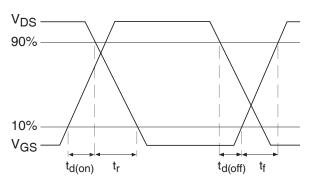


Fig 23b. Switching Time Waveforms

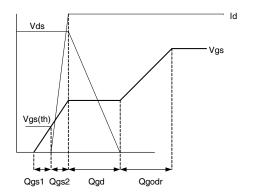
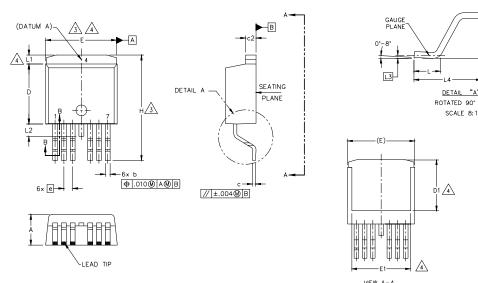
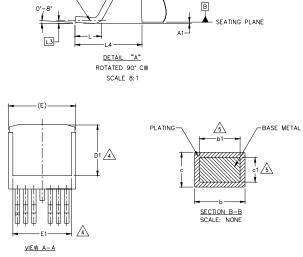


Fig 24b. Gate Charge Waveform

D²Pak - 7 Pin Package Outline

Dimensions are shown in millimeters (inches)





S	DIMENSIONS							
l M	MILLIM	ETERS	1	HES	N O T E S			
B O L	MIN.	MAX.	MIN.	MAX.	E S			
Α	4.06	4.83	.160	.190				
A1	_	0.254	_	.010				
Ь	0.51	0.99	.020	.036				
ь1	0.51	0.89	.020	.032	5			
С	0.38	0.74	.015	.029				
c1	0.38	0.58	.015	.023	5			
c2	1.14	1.65	.045	.065				
D	8.38	9.65	.330	.380	3			
D1	6.86	_	.270		4			
E	9.65	10.67	.380	.420	3,4			
E1	6.22	_	.245		4			
е	1.27	BSC	.050	BSC				
Н	14.61	15.88	.575	.625				
L	1.78	2.79	.070	.110				
L1	_	1.68	_	.066	4			
L2	_	1.78	_	.070				
L3	0.25	BSC	.010	BSC				
L4	4.78	5.28	.188	.208				

NOTES

- 1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263CB.

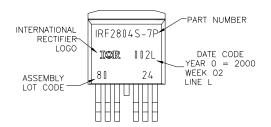
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

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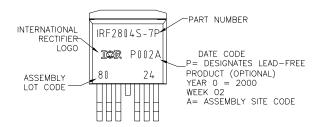
D²Pak - 7 Pin Part Marking Information

EXAMPLE: THIS IS AN IRF2804S-7P WITH LOT CODE 8024 ASSEMBLED ON WW02.2000 IN THE ASSEMBLY LINE "L'

Note: "P" in assembly line position indicates "Lead Free"



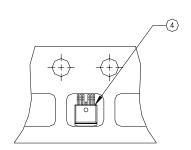
OR

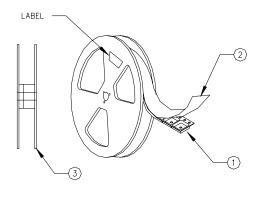


D²Pak - 7 Pin Tape and Reel

NOTES, TAPE & REEL, LABELLING:

- 1. TAPE AND REEL.
 - 1.1 REEL SIZE 13 INCH DIAMETER.
 - 1.2 EACH REEL CONTAINING 800 DEVICES.
 - THERE SHALL BE A MINIMUM OF 42 SEALED POCKETS CONTAINED IN THE LEADER AND A MINIMUM OF 15 SEALED POCKETS IN THE TRAILER.
 - 1.4 PEEL STRENGTH MUST CONFORM TO THE SPEC. NO. 71-9667.
 - 1.5 PART ORIENTATION SHALL BE AS SHOWN BELOW.
 - 1.6 REEL MAY CONTAIN A MAXIMUM OF TWO UNIQUE LOT CODE/DATE CODE COMBINATIONS. REWORKED REELS MAY CONTAIN A MAXIMUM OF THREE UNIQUE LOT CODE/DATE CODE COMBINATIONS. HOWEVER, THE LOT CODES AND DATE CODES WITH THEIR RESPECTIVE QUANTITIES SHALL APPEAR ON THE BAR CODE LABEL FOR THE AFFECTED REEL.
- 2. LABELLING (REEL AND SHIPPING BAG). 2.1 CUST. PART NUMBER (BAR CODE): IRFXXXXSTRL-7P 2.2 CUST. PART NUMBER (TEXT CODE): IRFXXXXSTRL-7P
 - 2.3 I.R. PART NUMBER: IRFXXXXSTRL-7P
 - 2.4 QUANTITY:
 - 2.5 VENDOR CODE: IR
 - 2.6 LOT CODE:
 - 2.7 DATE CODE:





Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/

Data and specifications subject to change without notice. This product has been designed and qualified for the Industrial market. Qualification Standards can be found on IR's Web site.



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TAC Fax: (310) 252-7903

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